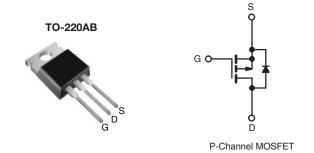


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 100				
$R_{DS(on)}(\Omega)$	V _{GS} = - 10 V 0.60				
Q _g (Max.) (nC)	18				
Q _{gs} (nC)	3.0				
Q _{gd} (nC)	9.0				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF9520PbF
	SiHF9520-E3
SnPb	IRF9520
	SiHF9520

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 100	V	
Gate-Source Voltage			V_{GS}	± 20		
Continuous Drain Current	V -1 40V	T _C = 25 °C		- 6.8	A	
Continuous Drain Current	V _{GS} at - 10 V	T _C = 100 °C	I _D	- 4.8		
Pulsed Drain Current ^a			I _{DM}	- 27		
Linear Derating Factor				0.40	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	300	mJ	
Repetitive Avalanche Currenta			I _{AR}	- 6.8	А	
Repetitive Avalanche Energy ^a			E _{AR}	6.0	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	60	W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for ⁻	10 s		300 ^d	0	
Mounting Toyaus	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 9.7 mH, R_g = 25 Ω , I_{AS} = 6.8 A (see fig. 12).
- c. $I_{SD} \le$ 6.8 A, $dI/dt \le$ 110 A/µs, $V_{DD} \le V_{DS}$, $T_J \le$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	2.5		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	- 100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = -1 mA		- 0.10	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	V _{DS} = V _{GS} , I _D = - 250 μA		-	- 4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zava Cata Valtaga Dvain Cuwant		V _{DS} = -	V _{DS} = - 100 V, V _{GS} = 0 V		-	- 100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 80 V,	V _{GS} = 0 V, T _J = 150 °C	-	-	- 500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 4.1 A ^b	-	-	0.60	Ω
Forward Transconductance	9 _{fs}	V _{DS} = - \$	50 V, I _D = - 4.1 A ^b	2.0	-	-	S
Dynamic							
Input Capacitance	C _{iss}	,	$V_{GS} = 0 \text{ V},$	-	390	-	pF
Output Capacitance	C _{oss}	V _I	os = - 25 V,	-	170	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0	f = 1.0 MHz, see fig. 5		45	-	1
Total Gate Charge	Qg			-	-	18	
Gate-Source Charge	Q_{gs}	V _{GS} = - 10 V	$I_D = -6.8 \text{ A}, V_{DS} = -80 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.0	nC
Gate-Drain Charge	Q _{gd}]		-	-	9.0	
Turn-On Delay Time	t _{d(on)}			-	9.6	-	
Rise Time	t _r	V_{DD} = - 50 V, I_{D} = - 6.8 A, R_{g} = 18 Ω, R_{D} = 7.1 Ω, see fig. 10 ^b		-	29	-	ns
Turn-Off Delay Time	t _{d(off)}			-	21	-	
Fall Time	t _f			-	25	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						,
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 6.8	Α
Pulsed Diode Forward Current ^a	I _{SM}			i	-	- 27	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = -6.8 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	ı	- 6.3	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = - 6.8 A, dl/dt = 100 A/μs ^b		-	98	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.33	0.66	μC
Forward Turn-On Time	t _{on}	Intrinsic turr	n-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

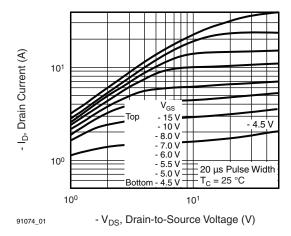


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

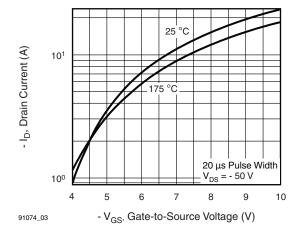


Fig. 3 - Typical Transfer Characteristics

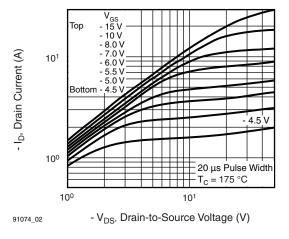


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

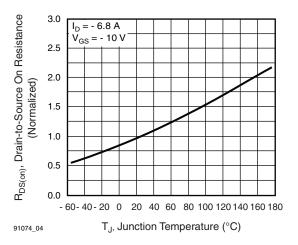


Fig. 4 - Normalized On-Resistance vs. Temperature



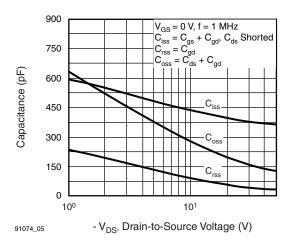


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

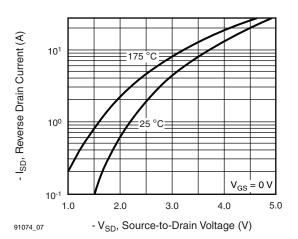


Fig. 7 - Typical Source-Drain Diode Forward Voltage

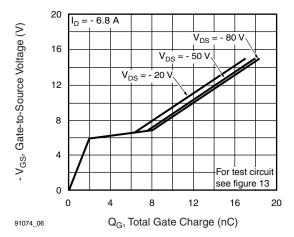


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

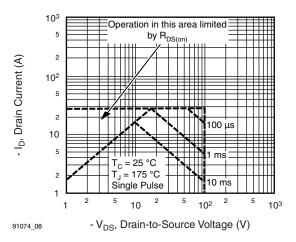


Fig. 8 - Maximum Safe Operating Area



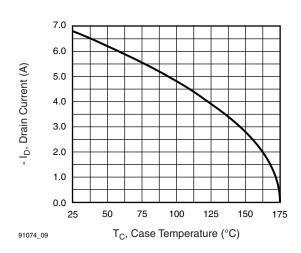


Fig. 9 - Maximum Drain Current vs. Case Temperature

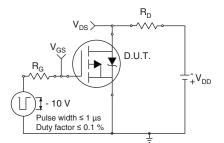


Fig. 10a - Switching Time Test Circuit

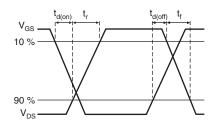


Fig. 10b - Switching Time Waveforms

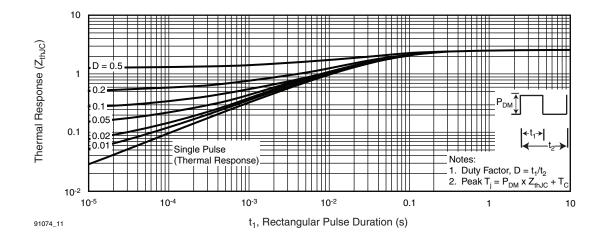


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



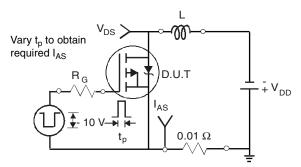


Fig. 12a - Unclamped Inductive Test Circuit

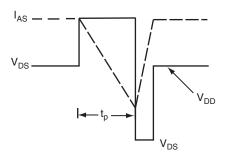


Fig. 12b - Unclamped Inductive Waveforms

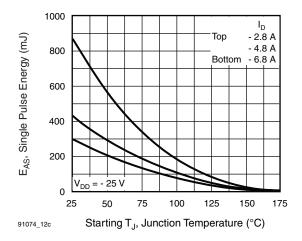


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

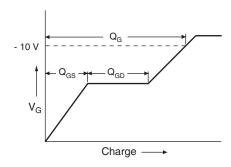


Fig. 13a - Basic Gate Charge Waveform

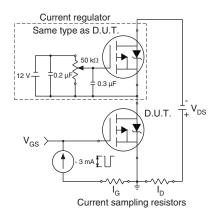
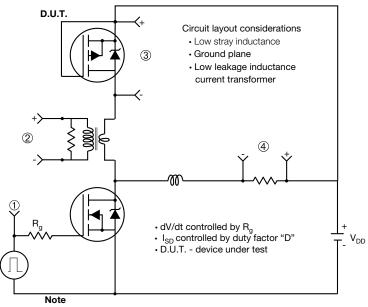


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

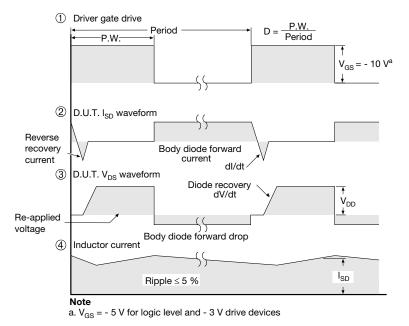


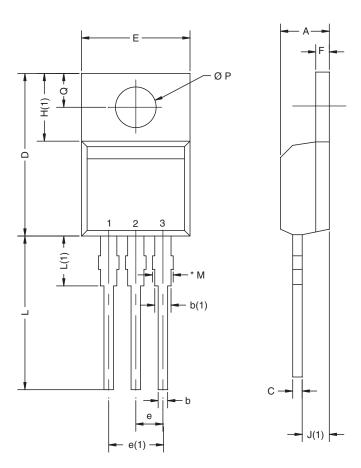
Fig. 14 - For P-Channel

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TO-220AB



	MILLIMETERS		INC	CHES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X10-0416-Rev. M, 01-Nov-10					

DWG: 5471

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM





Vishay

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